



FCC SAR TEST REPORT

Client Name : Shenzhen Beijia Electronic Technology Co., Ltd.

Address 2/F, No. 20 Xinkang 2nd Road, Shatian Community, Kengzi Street, Pingshan District, Shenzhen, China

Product Name : Walkie talkie

Date : Mar. 21, 2019

Shenzhen Anbotek Compliance Laboratory Limited

Shenzhen Anbotek Compliance Laboratory Limited

Address: 1/F, Building D, Sogood Science and Technology Park, SanweiCommunity, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755-26066440 Fax:(86)755-26014772 Email:service@anbotek.com

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TEST REPORT

Applicant	:	Shenzhen Beijia Electronic Technology Co., Ltd.
Manufacturer	:	Shenzhen Beijia Electronic Technology Co., Ltd.
Product Name	μê.	Walkie talkie
Model No.		T5 patients Annu and builder patients to
Trade Mark	۰.	N/A
Rating(s)	199	DC 6.0V from battery

Test Standard(s) : IEEE 1528-2013; IEC 62209-2:2010;ANSI/IEEE C95.1:2005; FCC 47 CFR Part 2 (2.1093:2013);

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the IEEE 1528-2013, IEC 62209-2:2010, FCC 47 CFR Part 2 (2.1093:2013), ANSI/IEEE C95.1:2005 requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Receipt Date of Test

Prepared By

Mar,19, 2019 Mar. 20, 2019~ Mar. 20, 2019

Bolomy Wang

(Engineer / Bobby Wang)

Meng Snavy

Reviewer

(Supervisor / Snowy Meng)

Sally zhoing

Approved & Authorized Signer

(Manager / Sally Zhang)

Shenzhen Anbotek Compliance Laboratory Limited

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Anbotek

Approved

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Version

Version No.	Date	Description			
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1. Statement of Compliance

The maximum results of Specific Absorption Rate (SAR) found during testing are as follows.

<Highest SAR Summary>

	Channel	Freewooner		Maximum Report S	SAR Results (W/kg)
Mode	Channel Separation	Frequency (MHz)	Position	100% duty cycle	50% duty cycle
FRS	12.5KHz	462.6375	Face-held	0.679	0.340
FRS	12.5KHz	462.6375	Body-Worn	1.260	0.630
FRS	12.5KHz	467.6375	Face-held	0.613	0.306
FRS	12.5KHz	467.6375	Body-Worn	1.288	0.644

This device is in compliance with Specific Absorption Rate (SAR) for general population/uncontrolled exposure limits (1.6 W/kg) specified in FCC 47 CFR part 2 (2.1093) and ANSI/IEEE C95.1-2005, and had been tested in accordance with the measurement methods and procedures specified in IEEE 1528-2013 and IEC 62209-2:2010

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2. General Information

2.1 Client Information

Applicant:	Shenzhen Beijia Electronic Technology Co., Ltd.
Address of Applicant:	2/F, No. 20 Xinkang 2nd Road, Shatian Community, Kengzi Street, Pingshan District, Shenzhen, China
Manufacture:	Shenzhen Beijia Electronic Technology Co., Ltd.
Address of Manufacture:	2/F, No. 20 Xinkang 2nd Road, Shatian Community, Kengzi Street, Pingshan District, Shenzhen, China

2.2 Testing Laboratory Information

Test Site:	Shenzhen Anbotek Compliance Laboratory Limited
Address:	1/F., Building 1, SEC Industrial Park, No.0409 Qianhai Road, Nanshan District,
	Shenzhen, Guangdong, China

2.3 Description of Equipment Under Test (EUT)

Name of EUT:	Walkie talkie
Model Number:	T5
Power Supply:	DC 6V from battery
Frequency Range:	FRS: 462.5625MHz~462.7125MHz FRS: 467.5625MHz~467.7125MHz
Rate Power:	0.5W
Modulation Type:	FM
Channel Separation:	12.5KHz
Antenna Type:	Integral antenna
Antennal Gain:	-9.7dBi

2.4 Device Category and SAR Limits

This device belongs to portable device category because its radiating structure is allowed to be used within 20 centimeters of the body of the user. according to IEEE Std C95.1, 1999:((IEEE Standard for SafetyLevelswith Respect to Human Exposure to Radio Frequency Electromagnetic Fields, 3 KHz to 300 GHz).

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It specifies the maximum exposure limit of 1.6 W/kg as averaged over any 1 gram of tissue for portable devices being used within 20 cm of the user in the uncontrolled environment.

2.5 Applied Standard

The Specific Absorption Rate (SAR) testing specification, method, and procedure for this device is in accordance with the following standards:

- IEEE 1528-2013
- FCC 47 CFR Part 2 (2.1093:2013)
- ANSI/IEEE C95.1:2005
- IEC 62209-2:2010
- KDB 447498 D01
- KDB 865664 D01
- KDB 865664 D02

2.6 Environment of Test Site

	Items	Required	Actual
	Temperature (°C)	18-25	22~23
10	Humidity (%RH)	30-70	55~65

2.7 Test Configuration

Face-Held Configuration

Face-held Configuration- per FCC KDB447498 "A test separation distance of 25 mm must be applied for in-front-of the face SAR test exclusion and SAR measurements."

Body-worn Configuration

Body-worn measurements-per FCC KDB447498 "When body-worn accessory SAR testing is required, the body-worn accessory requirements in section 4.2.2 should be applied. PTT two-way radios that support held-to-ear operating mode must also be tested according to the exposure configurations required for handsets. This generally does not apply to cellphones with PTT options that have already been tested in more conservative configurations in applicable wireless modes for SAR compliance at 100% duty factor."

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3. Specific Absorption Rate (SAR)

Anbotek Testing

Anbotek 安博检测

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3.1 Introduction

Product Safety

SAR is related to the rate at which energy is absorbed per unit mass in an object exposed to a radio field. The SAR distribution in a biological body is complicated and is usually carried out by experimental techniques or numerical modeling. The standard recommends limits for two tiers of groups, occupational/controlled and general population/uncontrolled, based on a person's awareness and ability to exercise control over his or her exposure. In general, occupational/controlled exposure limits are higher than the limits for general population/uncontrolled.

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3.2 SAR Definition

The SAR definition is the time derivative (rate) of the incremental energy (dW) absorbed by (dissipated in) an incremental mass (dm) contained in a volume element (dv) of a given density (ρ). The equation description is as below:

$$SAR = \frac{d}{dt} \left(\frac{dW}{dm} \right) = \frac{d}{dt} \left(\frac{dW}{\rho dv} \right)$$

SAR is expressed in units of Watts per kilogram (W/kg)

SAR measurement can be either related to the temperature elevation in tissue by

$$SAR = C\left(\frac{\delta T}{\delta t}\right)$$

Where: C is the specific head capacity, δT is the temperature rise and δt is the exposure duration, or related to the electrical field in the tissue by

$$SAR = \frac{\sigma |E|^2}{\rho}$$

Where: σ is the conductivity of the tissue, ρ is the mass density of the tissue and E is the RMS electrical field strength.

However for evaluating SAR of low power transmitter, electrical field measurement is typically applied.

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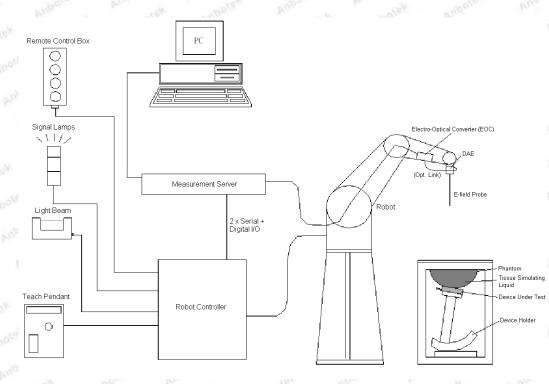
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4. SAR Measurement System



DASY System Configurations

The DASYsystem for performance compliance tests is illustrated above graphically. This system consists of the following items:

- > A standard high precision 6-axis robot with controller, a teach pendant and software
- A data acquisition electronic (DAE) attached to the robot arm extension
- A dosimetric probe equipped with an optical surface detector system
- > The electro-optical converter (EOC) performs the conversion between optical and electrical signals
- A measurement server performs the time critical tasks such as signal filtering, control of the robot
- operation and fast movement interrupts.
- A probe alignment unit which improves the accuracy of the probe positioning
- A computer operating Windows XP
- DASY software
- Remove control with teach pendant and additional circuitry for robot safety such as warming lamps, etc.
- > The SAM twin phantom
- A device holder
- Tissue simulating liquid
- Dipole for evaluating the proper functioning of the system

components are described in details in the following sub-sections.

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4.1 E-Field Probe

The SAR measurement is conducted with the dosimetric probe (manufactured by SPEAG). The probe is specially designed and calibrated for use in liquid with high permittivity. The dosimetric probe has special calibration in liquid at different frequency. This probe has a built in optical surface detection system to prevent from collision with phantom.

E-Field Probe Specification

<ex3dv4 p<="" th=""><th>'robe></th></ex3dv4>	'robe>

- 6	Construction	Symmetrical design with triangular core	
		Built-in shielding against static charges	
2		PEEK enclosure material (resistant to	
210		organic solvents, e.g., DGBE)	
	Frequency	10 MHz to 6 GHz; Linearity: ± 0.2 dB	2.9
27	Directivity	\pm 0.3 dB in HSL (rotation around probe	10
		axis)	
		\pm 0.5 dB in tissue material (rotation	
6		normal to probe axis)	1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1
10	Dynamic Range	10μ W/g to $100 m$ W/g; Linearity: $\pm 0.2 d$ B	
		(noise: typically $< 1 \mu W/g$)	STO TO THE REAL OF
ŝ	Dimensions	Overall length: 330 mm (Tip: 20 mm)	Photo of EX3DV4
3		Tip diameter: 2.5 mm (Body: 12 mm)	hebota hnu dak
		Typical distance from probe tip to dipole	Anboice Anon A
		centers: 1 mm	tel population population

E-Field Probe Calibration

Each probe needs to be calibrated according to a dosimetric assessment procedure with accuracy better than \pm 10%. The spherical isotropy shall be evaluated and within \pm 0.25dB. The sensitivity parameters (NormX, NormY, and NormZ), the diode compression parameter (DCP) and the conversion factor (ConvF) of the probe are tested. The calibration data can be referred to appendix C of this report.

4.2 Data Acquisition Electronics (DAE)

The data acquisition electronics (DAE) consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the measurement server is accomplished through an optical downlink for data and status information as well as an optical uplink for commands and the clock.

The input impedance of the DAE is 200MOhm; the inputs are symmetrical and floating. Common mode rejection is above 80dB.

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Photo of DAE

4.3 Robot

The SPEAG DASY system uses the high precision robots (DASY5: TX60XL) type from Stäubli SA (France). For the 6-axis controllersystem, the robot controller version (DASY5: CS8c) from Stäubli is used. The Stäublirobot series have many features that are important for our application:

- ▶ High precision (repeatability ±0.035 mm)
- High reliability (industrial design)
- Jerk-free straight movements
- > Low ELF interference (the closed metallic construction shields against motor control fields)



Photo of DASY5

4.4 Measurement Server

The measurement server is based on a PC/104 CPU board with CPU (DASY5: 400 MHz, Intel Celeron), chipdisk (DASY5: 128 MB), RAM (DASY5: 128 MB). The necessary circuits for communication with the DAE electronic box, as well as the 16 bit AD converter system for optical detection and digital I/O interface

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are contained on the DASY I/O board, which is directly connected to the PC/104 bus of the CPU board.

The measurement server performs all the real-time data evaluation for field measurements and surface detection, controls robot movements and handles safety operations.



Photo of Server for DASY5

4.5 Phantom

<SAM Twin Phantom>

Shell Thickness $2 \pm 0.2 \text{ mm};$
Center ear point: 6 ± 0.2 mm
Filling Volume Approx. 25 liters
Dimensions Length: 1000 mm; Width: 500 mm;
Height: adjustable feet
Measurement Areas Left Hand, Right Hand, Flat Phantom

Photo of SAM Phantom

The bottom plate contains three pair of bolts for locking the device holder. The device holder positions are adjusted to the standard measurement positions in the three sections. A white cover is provided to tap the phantom during off-periods to prevent water evaporation and changes in the liquid parameters. On the phantom top, three reference markers are provided to identify the phantom position with respect to the robot.

<ELI4 Phantom>

and and the	20 Store 10 Store 10 10 10 10 10 10 10 10 10 10 10 10 10
Shell Thickness	2 ± 0.2 mm (sagging: <1%)
Filling Volume	Approx. 30 liters
Dimensions	Major ellipse axis: 600 mm
	Minor axis:400 mm
	anter Mano - Proder Mander -
	wolker appendent print and
	And and manager And a second
	Andrew Andrew Methods M
	antiother and tek spaces Antion Attended insoler
	Photo of ELI4 Phantom
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The ELI4 phantom is intended for compliance testing of handheld and body-mounted wireless devices in the frequency range of 30 MHz to 6 GHz. ELI4 is fully compatible with standard and all known tissue simulating liquids.

4.6 Device Holder

The SAR in the phantom is approximately inversely proportional to the square of the distance between the source and the liquid surface. For a source at 5 mm distance, a positioning uncertainty of ± 0.5 mm would produce a SAR uncertainty of $\pm 20\%$. Accurate device positioning is therefore crucial for accurate and repeatable measurements. The positions in which the devices must be measured are defined by the standards.

The DASY device holder is designed to cope with different positions given in the standard. It has two scales for the device rotation (with respect to the body axis) and the device inclination (with respect to the line between the ear reference points). The rotation center for both scales is the ear reference point (ERP). Thus the device needs no repositioning when changing the angles.

The DASY device holder is constructed of low-loss POM material having the following dielectric parameters: relative permittivity $\varepsilon = 3$ and loss tangent $\delta = 0.02$. The amount of dielectric material has been reduced in the closest vicinity of the device, since measurements have suggested that the influence of the clamp on the test results could thus be lowered.



Device Holder

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4.7 Data Storage and Evaluation

Data Storage

The DASY software stores the assessed data from the data acquisition electronics as raw data (in microvolt readings from the probe sensors), together with all the necessary software parameters for the data evaluation (probe calibration data, liquid parameters and device frequency and modulation data) in measurement files. The post-processing software evaluates the desired unit and format for output each time the data is visualized or exported. This allows verification of the complete software setup even after the measurement and allows correction of erroneous parameter settings. For example, if a measurement has been performed with an incorrect crest factor parameter in the device setup, the parameter can be corrected afterwards and the data can be reevaluated.

The measured data can be visualized or exported in different units or formats, depending on the selected probe type (e.g., [V/m], [A/m], [mW/g]). Some of these units are not available in certain situations or give meaningless results, e.g., a SAR-output in a non-lose media, will always be zero. Raw data can also be exported to perform the evaluation with other software packages.

Data Evaluation

The DASY post-processing software (SEMCAD) automatically executes the following procedures to calculate the field units from the microvolt readings at the probe connector. The parameters used in the evaluation are stored in the configuration modules of the software:

Probe parameters:	- Sensitivity	$Norm_i$, a_{i0} , a_{i1} , a_{i2}
	- Conversion factor	ConvF _i
	- Diode compression point	dcpi
Device parameters:	- Frequency	f
	- Crest factor	cf
Media parameters:	- Conductivity	σ
oten poten of	- Density	ρ

These parameters must be set correctly in the software. They can be found in the component documents or they can be imported into the software from the configuration files issued for the DASY components. In the direct measuring mode of the multi-meter option, the parameters of the actual system setup are used. In the scan visualization and export modes, the parameters stored in the corresponding document files are used.

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics. If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power.

The formula for each channel can be given as:

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Anbotek Product Safety Description

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$$V_i = U_i + U_i^2 \cdot \frac{ct}{dcp}$$

with V_i = compensated signal of channel i, (i = x, y, z)

 U_i = input signal of channel i, (i = x, y, z)

cf = crest factor of exciting field (DASY parameter)

 $dcp_i = diode \ compression \ point \ (DASY \ parameter)$

From the compensated input signals, the primary field data for each channel can be evaluated:

E-field Probes:
$$E_i = \sqrt{\frac{V_i}{Norm_i \cdot ConvF}}$$

H-field Probes:
$$\mathbf{H}_{i} = \sqrt{\mathbf{V}_{i}} \cdot \frac{\mathbf{a}_{i0} + \mathbf{a}_{i1}f + \mathbf{a}_{i2}f^{2}}{f}$$

with V_i = compensated signal of channel i,(i = x, y, z)

Norm_i= sensor sensitivity of channel i, (i = x, y, z), $\mu V/(V/m)^2$ for E-field Probes

ConvF= sensitivity enhancement in solution

 a_{ij} = sensor sensitivity factors for H-field probes

f = carrier frequency [GHz]

 E_i = electric field strength of channel i in V/m

 H_i = magnetic field strength of channel i in A/m

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$E_{tot} = \sqrt{E_x^2 + E_y^2 + E_z^2}$$

The primary field data are used to calculate the derived field units.

$$SAR = E_{tot}^2 \cdot \frac{\sigma}{\rho \cdot 1000}$$

with SAR = local specific absorption rate in mW/g

 E_{tot} = total field strength in V/m

 σ = conductivity in [mho/m] or [Siemens/m]

 ρ = equivalent tissue density in g/cm³

Note that the density is set to 1, to account for actual head tissue density rather than the density of the tissue simulating liquid.

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5. Test Equipment List

Manafaata		Tome (Madal	Sectol News	Calibration		
Manufacturer	Name of Equipment	Type/Model	Serial Number	Last Cal.	Due Date	
SPEAG	E-field Probe	EX3DV4	3836	2018-07-07	2019-07-06	
SPEAG	System Validation Dipole D450V3	D450V3	1079	2016-08-29	2019-08-28	
SPEAG	Data Acquisition Electronics	DAE4	1373	2018-03-22	2019-03-21	
Agilent	ENA Series Network Analyzer	E5071C	MY46317418	2018-05-23	2019-05-22	
SPEAG	DAK	DAK-3.5	1226	NCR	NCR	
SPEAG	SAM Twin Phantom	QD000P40CD	1802	NCR	NCR	
SPEAG	ELI Phantom	QDOVA004AA	2058	NCR	NCR	
AR	Amplifier	ZHL-42W	QA1118004	NCR	NCR	
Agilent	Power Meter	N1914A	MY50001102	2018-05-22	2019-05-21	
Agilent	Power Sensor	N8481H	MY51240001	2018-05-22	2019-05-21	
R&S	Spectrum Analyzer	N9020A	MY51170037	2018-05-22	2019-05-21	
Agilent	Signal Generation	N5182A	MY48180656	2018-05-22	2019-05-21	
Worken	Directional Coupler	0110A05601O-10	COM5BNW1A2	2018-05-22	2019-05-21	

Note:

2.

1. The calibration certificate of DASY can be referred to appendix C of this report.

- The dipole calibration interval can be extended to 3 years with justification. The dipoles are also not physically damaged, or repaired during the interval.
- . The Insertion Loss calibration of Dual Directional Coupler and Attenuator were characterized via the network analyzer and compensated during system check.
 - The dielectric probe kit was calibrated via the network analyzer, with the specified procedure (calibrated in pure water) and calibration kit (standard) short circuit, before the dielectric measurement. The specific procedure and calibration kit are provided by Agilent.
 - In system check we need to monitor the level on the power meter, and adjust the power amplifier level to have precise power level to the dipole; the measured SAR will be normalized to 1W input power according to the ratio of 1W to the input power to the dipole. For system check, the calibration of the power amplifier is deemed not critically required for correct measurement; the power meter is critical and we do have calibration for it

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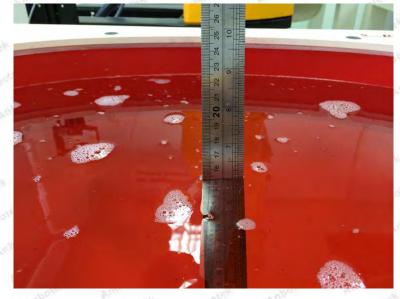


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6. Tissue Simulating Liquids

For the measurement of the field distribution inside the SAM phantom with DASY, the phantom must be filled with around 25 liters of homogeneous body tissue simulating liquid. For head SAR testing, the liquid height from the ear reference point (ERP) of the phantom to the liquid top surface is larger than 15 cm, which is shown in Fig. 6.1. For body SAR testing, the liquid height from the center of the flat phantom to the liquid top surface is larger than 15 cm, which is shown as followed:



Photograph of the depth in the Body Phantom (450MHz)

The following table gives the recipes for tissue simulating liquid.

	Composition	of the Head	Tissue	Equivalent Matte	r
--	-------------	-------------	--------	-------------------------	---

Mixture %	Frequency (Brain) 450MHz
Water	38.56
Sugar	56.32
Salt	3.95
Preventol	0.10
Cellulose	1.07
Dielectric Parameters Target Value	f=450MHz ε _r =43.5 σ=0.87
Composition of the Body	Tissue Equivalent Matter
Mixture %	Frequency (Brain) 450MHz
Water	56.16
Sugar	46.78
Salt	1.49
Preventol	0.10
Cellulose	0.47
Dielectric Parameters Target Value	f=450MHz ε _r =56.7 σ=0.94

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The following table shows the measuring results for simulating liquid.

Dielectric Performance of Head Tissue Simulating Liquid

Tiagua	Measured	Target	Tissue	Measure	ed Tissue	Dev	<i>r</i> . %	Liquid		
Tissue Type	Frequency	ε _r	σ	ε _r	σ	ε _r	σ	Liquid Temp.	Test Data	
450H	450	43.5	0.87	43.3	0.85	-0.46%	-2.30%	22.2 degree	2019-03-20	
450B	450	56.7	0.94	56.4	0.96	-0.53%	2.13%	22.2 degree	2019-03-20	

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7. System Verification Procedures

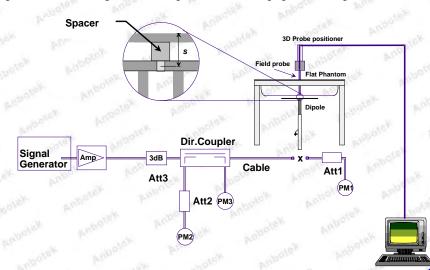
Each DASY system is equipped with one or more system validation kits. These units, together with the predefined measurement procedures within the DASY software, enable the user to conduct the system performance check and system validation. System validation kit includes a dipole, tripod holder to fix it underneath the flat phantom and a corresponding distance holder.

Purpose of System Performance check

The system performance check verifies that the system operates within its specifications. System and operator errors can be detected and corrected. It is recommended that the system performance check be performed prior to any usage of the system in order to guarantee reproducible results. The system performance check uses normal SAR measurements in a simplified setup with a well characterized source. This setup was selected to give a high sensitivity to all parameters that might fail or vary over time. The system check does not intend to replace the calibration of the components, but indicates situations where the system uncertainty is exceeded due to drift or failure.

System Setup

In the simplified setup for system evaluation, the EUT is replaced by a calibrated dipole and the power source is replaced by a continuous wave that comes from a signal generator. The calibrated dipole must be placed beneath the flat phantom section of the SAM twin phantom with the correct distance holder. The distance holder should touch the phantom surface with a light pressure at the reference marking and be oriented parallel to the long side of the phantom. The equipment setup is shown below:



System Setup for System Evaluation

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Photo of Dipole Setup

Validation Results

Comparing to the original SAR value provided by SPEAG, the verification data should be within its specification of 10 %. The table below shows the target SAR and measured SAR after normalized to 1W input power. It indicates that the system performance check can meet the variation criterion and the plots can be referred to Appendix A of this report.

System Check in Head Tissue Simulating Liquid 250mW Limit (±10% **1W Normalized** 1W Target **Test Date** Measured **Deviation**) Freq Temp SAR_{1g} SAR_{1g} SAR_{10g} SAR_{1g} SAR_{10g} SAR_{10g} SAR_{1g} SAR_{10g} 2019/03/20 22.2 0.780 4.664 4.58 450MHz 1.166 3.120 3.06 1.83% 1.96%

Freq	Test Date	Temp	250mW Temp Measured 1W Normalized		malized	1W Target		Limit (±10% Deviation)		
			SAR _{1g}	SAR _{10g}	SAR _{1g}	SAR _{10g}	SAR _{1g}	SAR _{10g}	SAR _{1g}	SAR _{10g}
450MHz	2019/03/20	22.2	1.147	0.765	4.588	3.060	4.60	3.03	-0.26%	0.99%

System Check in Body Tissue Simulating Liquid

Note:

1. The graph results see system check.

2. Target Values used derive from the calibration certificate

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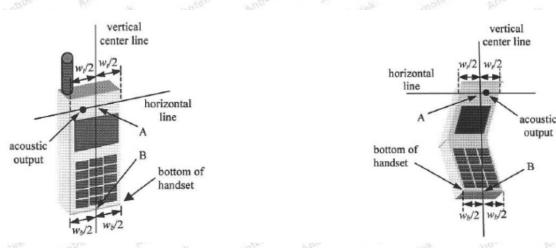
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8. EUT Testing Position

8.1. Define two imaginary lines on the handset

- (a) The vertical centerline passes through two points on the front side of the handset the midpoint of the width w_t of the handset at the level of the acoustic output, and the midpoint of the width w_b of the bottom of the handset.
- (b) The horizontal line is perpendicular to the vertical centerline and passes through the center of the acoustic output. The horizontal line is also tangential to the face of the handset at point A.
- (c) The two lines intersect at point A. Note that for many handsets, point A coincides with the center of the acoustic output; however, the acoustic output may be located elsewhere on the horizontal line. Also note that the vertical centerline is not necessarily parallel to the front face of the handset, especially for clamshell handsets, handsets with flip covers, and other irregularly shaped handsets.



Handset Vertical and Horizontal Reference Lines

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8.2. Position for Cheek/Touch

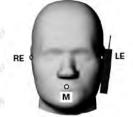
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- (a) To position the device with the vertical center line of the body of the device and the horizontal line crossing the center piece in a plane parallel to the sagittal plane of the phantom. While maintaining the device in this plane, align the vertical center line with the reference plane containing the three ear and mouth reference point (M: Mouth, RE: Right Ear, and LE: Left Ear) and align the center of the ear piece with the line RE-LE.
- (b) To move the device towards the phantom with the ear piece aligned with the line LE-RE until the phone touched the ear. While maintaining the device in the reference plane and maintaining the phone contact with the ear, move the bottom of the phone until any point on the front side is in contact with the cheek of the phantom or until contact with the ear is lost.





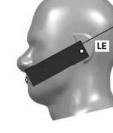


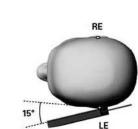
Cheek Position

8.3. Position for Ear / 15° Tilt

- (a) To position the device in the "cheek" position described above.
- (b) While maintaining the device the reference plane described above and pivoting against the ear, moves it outward away from the mouth by an angle of 15 degrees or until contact with the ear is lost (see Fig. 8.3).







Tilt Position

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8.4. Body Worn Position

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- (a) To position the device parallel to the phantom surface with either keypad up or down.
- (b) To adjust the device parallel to the flat phantom.
- (c) To adjust the distance between the device surface and the flat phantom to 0.5 cm.

Body Worn Position

mother phantom

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9. Measurement Procedures

The measurement procedures are as follows:

- (a) Use base station simulator (if applicable) or engineering software to transmit RF power continuously (continuous Tx) in the middle channel.
- (b) Keep EUT to radiate maximum output power or 100% duty factor (if applicable)
- (c) Measure output power through RF cable and power meter.
- (d) Place the EUT in the positions as setup photos demonstrates.
- (e) Set scan area, grid size and other setting on the DASY software.
- (f) Measure SAR transmitting at the middle channel for all applicable exposure positions.
- (g) Identify the exposure position and device configuration resulting the highest SAR
- (h) Measure SAR at the lowest and highest channels atthe worst exposure position and device configuration if applicable.

According to the test standard, the recommended procedure for assessing the peak spatial-average SAR value consists of the following steps:

- (a) Power reference measurement
- (b) Area scan
- (c) Zoom scan
- (d) Power drift measurement

9.1 Spatial Peak SAR Evaluation

The procedure for spatial peak SAR evaluation has been implemented according to the test standard. It can be conducted for 1g and 10g, as well as for user-specific masses. The DASY software includes all numerical procedures necessary to evaluate the spatial peak SAR value.

The base for the evaluation is a "cube" measurement. The measured volume must include the 1g and 10g cubes with the highest averaged SAR values. For that purpose, the center of the measured volume is aligned to the interpolated peak SAR value of a previously performed area scan.

The entire evaluation of the spatial peak values is performed within the post-processing engine (SEMCAD). The system always gives the maximum values for the 1g and 10g cubes. The algorithm to find the cube with highest averaged SAR is divided into the following stages:

- (a) Extraction of the measured data (grid and values) from the Zoom Scan
- (b) Calculation of the SAR value at every measurement point based on all stored data (A/D values and measurement parameters)
- (c) Generation of a high-resolution mesh within the measured volume
- (d) Interpolation of all measured values form the measurement grid to the high-resolution grid
- (e) Extrapolation of the entire 3-D field distribution to the phantom surface over the distance from sensor to

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(f) Calculation of the averaged SAR within masses of 1g and 10g

9.2 Power Reference Measurement

The Power Reference Measurement and Power Drift Measurements are for monitoring the power drift of the device under test in the batch process. The minimum distance of probe sensors to surface determines the closest measurement point to phantom surface. This distance cannot be smaller than the distance of sensor calibration points to probe tip as defined in the probe properties.

9.3 Area & Zoom Scan Procedures

The area scan is used as a fast scan in two dimensions to find the area of high field values, before doing afine measurement around the hot spot. The sophisticated interpolation routines implemented in DASYsoftware can find the maximum found in the scanned area, within a range of the global maximum. The range (in dB0 is specified in the standards for compliance testing. For example, a 2 dB range is required in IEEEstandard 1528 and IEC 62209 standards, whereby 3 dB is a requirement when compliance is assessed inaccordance with the ARIB standard (Japan), if only one zoom scan follows the area scan, then only theabsolute maximum will be taken as reference. For cases where multiple maximums are detected, the number of zoom scans has to be increased accordingly.

	≤3 GHz	>3 GHz
Maximum distance from closest measurement point (geometric center of probe sensors) to phantom surface	$5 \pm 1 \text{ mm}$	$\frac{1}{2} \cdot \delta \cdot \ln(2) \pm 0.5 \text{ mm}$
Maximum probe angle from probe axis to phantom surface normal at the measurement location	30° ± 1°	20°±1°
	≤ 2 GHz: ≤ 15 mm 2 – 3 GHz: ≤ 12 mm	3 – 4 GHz: ≤ 12 mm 4 – 6 GHz: ≤ 10 mm
Maximum area scan spatial resolution: $\Delta x_{\text{Area}}, \Delta y_{\text{Area}}$	When the x or y dimension of measurement plane orientation the measurement resolution x or y dimension of the test of measurement point on the test	on, is smaller than the above, must be \leq the corresponding levice with at least one

Area scan parameters extracted from FCC KDB 865664 D01 SAR measurement 100 MHz to 6 GHz.

9.4 Zoom Scan Procedures

Zoom scans are used assess the peak spatial SAR values within a cubic averaging volume containing 1 gram and 10 gram of simulated tissue. The zoom scan measures points (refer to table below) within a cube shoes base faces are centered on the maxima found in a preceding area scan job within the same procedure. When the measurement is done, the zoom scan evaluates the averaged SAR for 1 gram and 10 gram and displays these values next to the job's label.

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Zoom scan parameters extracted from FCC KDB 865664 D01 SAR measurement 100 MHz to 6 GHz.

		april and a second		- all and a second
Maximum zoom scan s	spatial reso	plution: Δx_{Zoom} , Δy_{Zoom}	≤ 2 GHz: ≤ 8 mm 2 - 3 GHz: ≤ 5 mm	$3 - 4 \text{ GHz} \le 5 \text{ mm}$ $4 - 6 \text{ GHz} \le 4 \text{ mm}$
Maximum zoom scan spatial resolution, normal to phantom	uniform	grid: ∆z _{Zoom} (n)	≤5 mm	$3 - 4 \text{ GHz:} \le 4 \text{ mm}$ $4 - 5 \text{ GHz:} \le 3 \text{ mm}$ $5 - 6 \text{ GHz:} \le 2 \text{ mm}$
	graded	$\Delta z_{Zoom}(1)$: between 1 st two points closest to phantom surface	\leq 4 mm	3 – 4 GHz: ≤ 3 mm 4 – 5 GHz: ≤ 2.5 mm 5 – 6 GHz: ≤ 2 mm
	grid	Δz _{Zoom} (n>1): between subsequent points	$\leq 1.5 \cdot \Delta z$	z _{Zoom} (n-1)
Minimum zoom scan volume	x, y, z	,	\geq 30 mm	3 – 4 GHz: ≥ 28 mm 4 – 5 GHz: ≥ 25 mm 5 – 6 GHz: ≥ 22 mm

Note: δ is the penetration depth of a plane-wave at normal incidence to the tissue medium; see draft standard IEEE P1528-2011 for details.

When zoom scan is required and the <u>reported</u> SAR from the area scan based 1-g SAR estimation procedures of KDB 447498 is ≤ 1.4 W/kg, ≤ 8 mm, ≤ 7 mm and ≤ 5 mm zoom scan resolution may be applied, respectively, for 2 GHz to 3 GHz, 3 GHz to 4 GHz and 4 GHz to 6 GHz.

9.5 Volume Scan Procedures

The volume scan is used for assess overlapping SAR distributions for antennas transmitting in different frequency bands. It is equivalent to an oversized zoom scan used in standalone measurements. The measurement volume will be used to enclose all the simultaneous transmitting antennas. For antennas transmitting simultaneously in different frequency bands, the volume scan is measured separately in each frequency band. In order to sum correctly to compute the 1g aggregate SAR, the EUT remain in the same test position for all measurements and all volume scan use the same spatial resolution and grid spacing. When all volume scan were completed, the software, SEMCAD postprocessor can combine and subsequently superpose these measurement data to calculating the multiband SAR.

9.6 **Power Drift Monitoring**

The Power Drift Measurement measures the field at the same location as the most recent power reference measurement within the same procedure, and with the same settings. The Power Drift Measurement gives the field difference in dB from the reading conducted within the same settings. This allows a user to monitor the power drift of the device under test within a batch process. The measurement procedure is the same as Step 1.

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10.E.I.R.P Power

<FRS ERP Power>

According KDB 447498 D01 General RF Exposure Guidance v06 ection 4.1 2) states that "Unless it is specified differently in the published RF exposure KDB procedures, these requirements also apply to test reduction and test exclusion considerations. Time-averaged maximum conducted output power applies to SAR and, as required by § 2.1091(c), time-averaged ERP applies to MPE. When an antenna port is not available on the device to support conducted power measurement, such as FRS and certain Part 15 transmitters with built-in integral antennas, the maximum output power allowed for production units should be used to determine RF exposure test exclusion and compliance."

SAR may be scaled if radio is tested at lower power without overheating as invalid SAR results cannot be scaled to compensate for power droopaccording to October 2015TCB Workshop.

Medulation Turne	Channel	Test	Measured AverageERP F	ower
Modulation Type	Separation	Frequency	(dBm)	(Watts)
FM	12.5KHz	462.6375	26.54	0.451
FM	12.5KHz	467.6375	26.73	0.471

Manufacturing tolerance

	FRS (Average ERP Power)					
Frequency (MHz)	462.6375	467.6375				
Target (dBm)	26.00	26.00				
Tolerance ±(dB)	1.0	1.0				

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11.Transmit Antennas

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12. Standalone SAR Test Exclusion Considerations

Per KDB447498 for standalone 1-g head or body SAR evaluation by measurement or numerical simulation is not required when the corresponding SAR Exclusion Threshold condition, listed below, is satisfied.

The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances \leq 50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW) / (min. test separation distance, mm)] \cdot [\checkmark f(GHz)] \leq 3.0 for 1-g SAR and \leq 7.5 for 10-g extremity SAR, where

- •f(GHz) is the RF channel transmit frequency in GHz
- •Power and distance are rounded to the nearest mW and mm before calculation
- The result is rounded to one decimal place for comparison
- •3.0 and 7.5 are referred to as the numeric thresholds in the step 2 below

		Standalone SA	AR test excl	usion consid	lerations		
Communication system	Frequency (MHz)	Configuration	Maximum Average Power (dBm)	Separation Distance (mm)	Calculation Result	SAR Exclusion Thresholds	Standalone SAR Exclusion
EDC ANTRE	400 0075	Head Face	27	25	13.6	3.0	no
FRS	462.6375	Body worn	27	5	68.2	3.0	no
FDO	407 0075	Head Face	27	25	13.7	3.0	no
FRS	467.6375	Body worn	27	5	68.5	3.0	no

Remark: When the minimum test separation distance is < 5 mm, a distance of 5 mm applied to determine SAR test exclusion

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13.SAR Test Results Summary

General Note:

- The calculated SAR is obtained by the following formula:
- Reported SAR=Measured SAR×10^{(PTarget-PMeasured)/10}
- Where P_{Target} is the power of manufacturing upper limit;
- P_{Measured} is the measured power

					1							
					Measu	irement			Repo	orted		
		Maximum			SA	R _{1-g}			SA	R _{1-g}	SAR	
Test		Allowed	Measured	Test	(\	//Kg)	Power	Scaling	(W	/kg)	limit	Ref.
Frequency	Mode	Power	ERP	Configuration	100%	50%	drift	Factor	100%	50%	1g	Plot
MHz		(dBm)	(dBm)		Duty	Duty			Duty	Duty	(W/kg)	
					Cycle	Cycle			Cycle	Cycle		
		•	The EUT	display towards	ground for	12.5 KHz(/	Analog, fa	ce held)				
462.6375	FRS	27.00	26.54	Face Held	0.612	0.306	-0.05	1.11	0.679	0.340	1.60	1
467.6375	FRS	27.00	26.73	Face Held	0.578	0.289	-0.02	1.06	0.613	0.306	1.60	2
	•		The EUT d	isplay towards g	round for 1	12.5 KHz(A	nalog, Bo	dy-Worn)				
462.6375	FRS	27.00	26.54	Body Worn	1.135	0.568	-0.03	1.11	1.260	0.630	1.60	3
467.6375	FRS	27.00	26.73	Body Worn	1.215	0.608	0.04	1.06	1.288	0.644	1.60	4
	6.13		1 A 10	104.56	100		1.05	- 01				

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14.SAR Measurement Variability

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SAR measurement variability must be assessed for each frequency band, which is determined by the SAR probe calibration point and tissue-equivalent medium used for the device measurements. When both head and body tissue-equivalent media are required for SAR measurements in a frequency band, the variability measurement procedures should be applied to the tissue medium with the highest measured SAR, using the highest measured SAR configuration for that tissue-equivalent medium. The following procedures are applied to determine if repeated measurements are required.

- Repeated measurement is not required when the original highest measured SAR is < 0.80 W/kg; steps 2) through 4) do not apply.
- 2) When the original highest measured SAR is ≥ 0.80 W/kg, repeat that measurement once.
- 3) Perform a second repeated measurement only if the ratio of largest to smallest SAR for the original and first repeated measurements is > 1.20 or when the original or repeated measurement is ≥ 1.45 W/kg (~ 10% from the 1-g SAR limit).
- Perform a third repeated measurement only if the original, first or second repeated measurement is ≥ 1.5 W/kg and the ratio of largest to smallest SAR for the original, first and second repeated measurements is > 1.20.

The same procedures should be adapted for measurements according to extremity and occupational exposure limits by applying a factor of 2.5 for extremity exposure and a factor of 5 for occupational exposure to the corresponding SAR thresholds.

			Depented	Highest	First Re	peated
Frequency (MHz)	Mode	Test Position	Repeated SAR	Measured	Measured	Largest to Smallest SAR
			(yes/no)	SAR _{1-g}	SAR _{1-g}	
				(W/kg)	(W/kg)	Ratio
462.6375	CW	Body-worn	yes	1.135	1.141	1.005
467.6375	CW	Body-worn	yes	1.215	1.221	1.005

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15.Simultaneous Transmission Analysis

The DUT, with FRS function and only one antenna equipped, no simultaneous transmission need consideration.

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16.Measurement Uncertainty

NO	Source	Uncert. ai (%)	Prob. Dist.	Div. k	ci (1g)	ci (10g)	cert. ui (1g)	Stand.Un cert. ui (10g)	Veff
1. N ^{elt}	Repeat	0.4	N	I COL	1	1	0.4	0.4	9
nstru	iment						T		
2	Probe calibration	7	N	2	10	1	3.5	3.5	œ
3	Axial isotropy	4.7	R	$\sqrt{3}$	0.7	0.7	1.9	1.9	œ
4	Hemispherical isotropy	9.4	R	$\sqrt{3}$	0.7	0.7	3.9	3.9	8
5	Boundary effect	1.0	R	$\sqrt{3}$	nbolsk	1 13	0.6	0.6	8
6	Linearity	4.7	R	$\sqrt{3}$	p.100%	1	2.7	2.7	00
7	Detection limits	1.0	R	$\sqrt{3}$	1	obdiek	0.6	0.6	œ
8	Readout electronics	0.3	N	1	1	Albas	0.3	0.3	8
9	Response time	0.8	R	$\sqrt{3}$	norte la h	6 1 ^{p.11}	0.5	0.5	œ
10	Integration time	2.6	R	$\sqrt{3}$	1 _{ben}	1	1.5	1.5	œ
11	Ambient noise	3.0	R	$\sqrt{3}$	1	1 suppu	1.7	1.7	8
12	Ambient reflections	3.0	R	$\sqrt{3}$	inol1"	1 -	1.7	1.7	8
13	Probe positioner mech. restrictions	0.4	R	$\sqrt{3}$	Anboro 1 Anb	¥1	0.2	0.2	8
14	Probe positioning with respect to phantom shell	2.9	R	$\sqrt{3}$	ak 1	holo holo	1.7	1.7	8
15	Max.SAR evaluation	1.0	R	$\sqrt{3}$	Astantel	1	0.6	0.6	œ

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Product Safety Report No.: R0219020005W

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			υ.	2/10	10	

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Test s	sample related								
16	Device positioning	3.8	N	notek 1	8-18	nator 1 Nator	3.8	3.8	99
17	Device holder	5.1	N	1,00	allak 1	1,000	5.1	5.1	5
18	Drift of output power	5.0	R	$\sqrt{3}$	1	o [™] 1	2.9	2.9	8
Phan	tom and set-up								
19	Phantom uncertainty	4.0	R	$\sqrt{3}$	1	hindonia 1	2.3	2.3	8
20	Liquid conductivity (target)	5.0	R	$\sqrt{3}$	0.64	0.43	1.8	1.2	8
21	Liquid conductivity (meas)	2.5	N	on 12	0.64	0.43	1.6	1.2	œ
22	Liquid Permittivity (target)	5.0	R	$\sqrt{3}$	0.6	0.49	1.7	1.5	8
23	Liquid Permittivity (meas)	2.5	N	1	0.6	0.49	1.5	1.2	œ
Con	abined standard	Active Active Active	RSS	U _c	$=\sqrt{\sum_{i=1}^{n}C}$	$U_i^2 U_i^2$	11.4%	11.3%	236
100	anded ertainty(P=95%)	hotak	U =k L	∕ _c ,k=	2	per peri	22.8%	22.6%	Anto

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Appendix A. EUT Photos and Test Setup Photos



Face-held, the front of the EUT towards phantom (The distance was 25mm)

Body-worn, the front of the EUT towards ground (The distance was 0mm)

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Appendix B. Plots of SAR System Check

System Performance Check at 450 MHz Head TSL

DUT: Dipole450 MHz; Type: D450V3; Serial: 1079

Date/Time: 03/20/2019

Communication System: PTT 450; Frequency: 450 MHz; Duty Cycle: 1:1 Medium parameters used (interpolated): f = 450 MHz; σ = 0.85 S/m; ϵ_r = 43.3; ρ = 1000 kg/m³ Phantom section: Flat Section

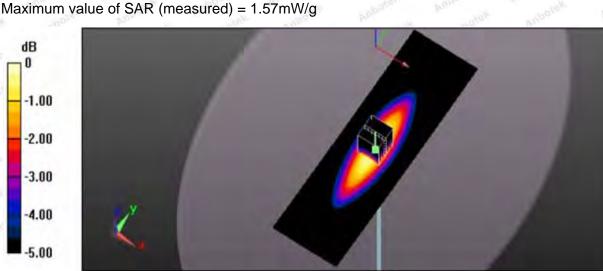
DASY5 Configuration:

- Probe: ES3DV4 –SN3836; ConvF(7.12, 7.12, 7.12); Calibrated: 07/07/2018;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn1373; Calibrated: 03/22/2018
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670;
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Area Scan (61x201x1):Interpolated grid: dx=1.500 mm, dy=1.50 mm Maximum value of SAR (interpolated) = 1.37mW/g

Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm Reference Value = 39.85 V/m; Power Drift = -0.03dB Peak SAR (extrapolated) = 1.54mW/g

SAR(1 g) =1.166 mW/g; SAR(10 g) = 0.780 mW/g



0 dB = 1.57 mW/g System Performance Check 450MHz Head 250mW

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System Performance Check at 450 MHz Body TSL

DUT: Dipole450 MHz; Type: D450V3; Serial: 1079 Date/Time: 03/20/2019 Communication System: PTT 450; Frequency: 450 MHz;Duty Cycle: 1:1 Medium parameters used (interpolated): f = 450 MHz; σ = 0.96 S/m; ϵ_r = 56.4; ρ = 1000 kg/m³ Phantom section: Flat Section

DASY5 Configuration:

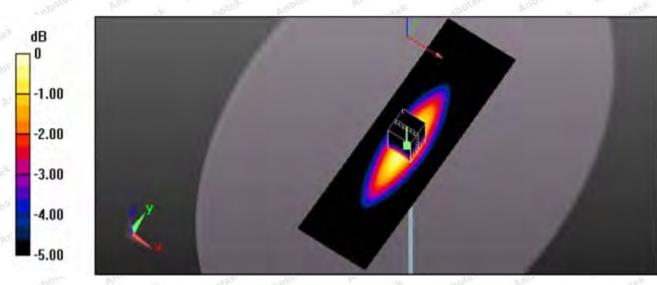
- Probe: ES3DV4 –SN3836; ConvF(7.33, 7.33, 7.33); Calibrated: 07/07/2018;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn1373; Calibrated: 03/22/2018
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670;
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Area Scan (61x201x1):Interpolated grid: dx=1.500 mm, dy=1.50 mm Maximum value of SAR (interpolated) = 1.42mW/g

Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm Reference Value = 41.55 V/m; Power Drift = 0.05 dB Peak SAR (extrapolated) = 1.61mW/g

SAR(1 g) = 1.147 mW/g; SAR(10 g) = 0.765 mW/g

Maximum value of SAR (measured) = 1.75mW/g



0 dB = 1.75mW/g System Performance Check 450MHz Body 250mW

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Appendix C. Plots of SAR Test Data

SAR plots for the highest measured SAR in each ex

posure configuration, wireless mode and frequency band combination according to FCC KDB 865664 D02

Face Held for FM Modulation at 12.5KHz Channel Separation, Front towards Phantom 462.6375MHz

Date: 03/20/2019

Communication System: PTT 450; Frequency: 462.6375 MHz;Duty Cycle:1:1 Medium parameters used (interpolated): f = 463.0 MHz; σ = 0.88 S/m; ϵ_r = 43.7; ρ = 1000 kg/m³ Phantom section: Flat Section

DASY5 Configuration:

- Probe: ES3DV4 SN3836; ConvF(7.12, 7.12, 7.12); Calibrated: 07/07/2018;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn1373; Calibrated: 03/22/2018
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670;
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Area Scan (51x81x1): Interpolated grid: dx=1.500 mm, dy=1.500 mm

Maximum value of SAR (interpolated) = 0.710 W/kg

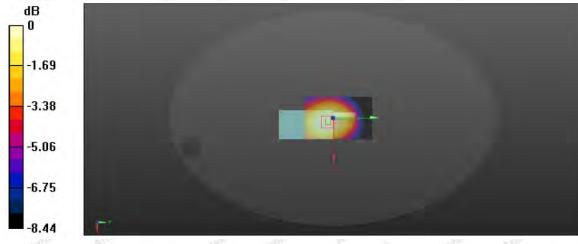
Zoom Scan (5x5x7)/Cube 0: Measurement grid: dx=8mm, dy=8mm, dz=5mm

Reference Value = 19.35 V/m; Power Drift = -0.05 dB

Peak SAR (extrapolated) = 0.834 W/kg

SAR(1 g) = 0.612 W/kg; SAR(10 g) = 0.257 W/kg

Maximum value of SAR (measured) = 0.910 W/kg



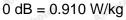


Figure 1: Face held for FM Modulation at 12.5KHz Channel Separation Front towards Phantom462.6375 MHz

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Face Held for FM Modulation at 12.5KHz Channel Separation, Front towards Phantom 467.6375MHz

Date: 03/20/2019

Communication System: PTT 450; Frequency: 467.6375 MHz;Duty Cycle:1:1 Medium parameters used (interpolated): f = 468.0 MHz; σ = 0.89 S/m; ϵ_r = 43.8; ρ = 1000 kg/m³ Phantom section: Flat Section

DASY5 Configuration:

- Probe: ES3DV4 –SN3836; ConvF(7.12, 7.12, 7.12); Calibrated: 07/07/2018;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn1373; Calibrated: 03/22/2018
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670;
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

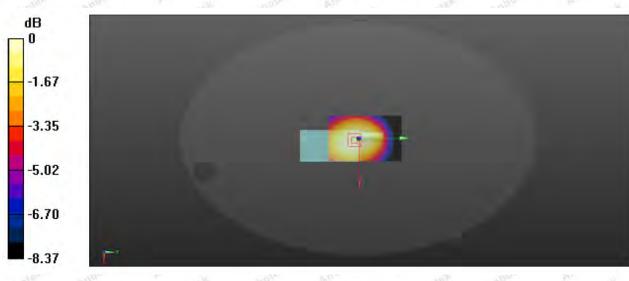
Area Scan (51x81x1): Interpolated grid: dx=1.500 mm, dy=1.500 mm

Maximum value of SAR (interpolated) = 0.688 W/kg

Zoom Scan (5x5x7)/Cube 0: Measurement grid: dx=8mm, dy=8mm, dz=5mm Reference Value = 19.59 V/m; Power Drift = -0.02 dB Peak SAR (extrapolated) = 0.719 W/kg

SAR(1 g) = 0.578 W/kg; SAR(10 g) = 0.243 W/kg

Maximum value of SAR (measured) = 0.855 W/kg



0 dB = 0.855 W/kg

Figure 1: Face held for FM Modulation at 12.5KHz Channel Separation Front towards Phantom467.6375 MHz

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Body- Worn FM Modulation at 12.5KHz Channel Separation, Front towards Ground 462.6375MHz

Date: 03/20/2019

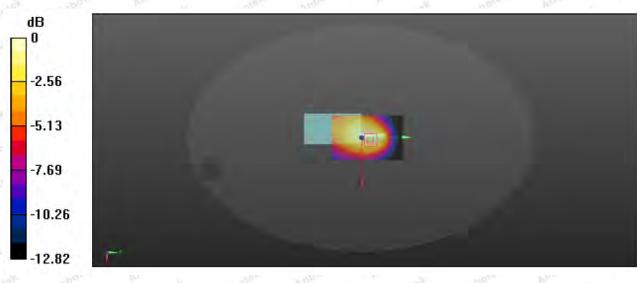
Communication System: PTT 450; Frequency: 462.6375 MHz;Duty Cycle:1:1 Medium parameters used (interpolated): f = 463.0 MHz; σ = 0.97S/m; ϵ_r = 56.8; ρ = 1000 kg/m³ Phantom section : Flat Section

DASY5 Configuration:

- Probe: ES3DV4 SN3836; ConvF(7.33, 7.33, 7.33); Calibrated: 07/07/2018;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn1373; Calibrated: 03/22/2018
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670;
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Area Scan (51x81x1): Interpolated grid: dx=1.500 mm, dy=1.500 mm Maximum value of SAR (interpolated) = 1.57 W/kg

Zoom Scan (5x5x7)/Cube 0: Measurement grid: dx=8mm, dy=8mm, dz=5mm Reference Value = 35.13 V/m; Power Drift = -0.03 dB Peak SAR (extrapolated) = 1.95 W/kg SAR(1 g) = 1.135 W/kg; SAR(10 g) = 0.689 W/kg Maximum value of SAR (measured) = 2.05 W/kg



0 dB = 2.05 W/kg

Figure 3: Body-worn for FM Modulation at 12.5KHz Channel Separation; Front towards Ground462.6375 MHz

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Body- Worn FM Modulation at 12.5KHz Channel Separation, Front towards Ground 467.6375MHz

Date: 03/20/2019

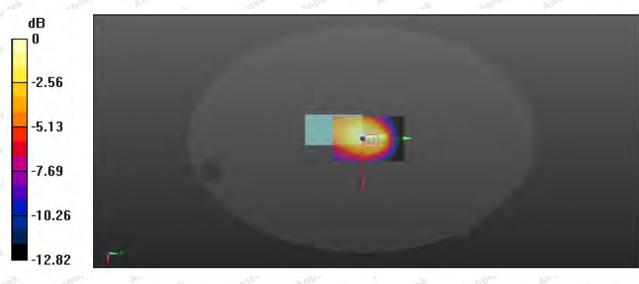
Communication System: PTT 450; Frequency: 467.6375 MHz;Duty Cycle:1:1 Medium parameters used (interpolated): f = 468.0 MHz; σ = 0.98S/m; ϵ_r = 56.9; ρ = 1000 kg/m³ Phantom section : Flat Section

DASY5 Configuration:

- Probe: ES3DV4 SN3836; ConvF(7.33, 7.33, 7.33); Calibrated: 07/07/2018;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn1373; Calibrated: 03/22/2018
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670;
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Area Scan (51x81x1): Interpolated grid: dx=1.500 mm, dy=1.500 mm Maximum value of SAR (interpolated) = 1.65 W/kg

Zoom Scan (5x5x7)/Cube 0: Measurement grid: dx=8mm, dy=8mm, dz=5mm Reference Value = 37.85 V/m; Power Drift = 0.04 dB Peak SAR (extrapolated) = 2.15 W/kg SAR(1 g) = 1.215 W/kg; SAR(10 g) = 0.725 W/kg Maximum value of SAR (measured) = 2.48 W/kg



0 dB = 2.48 W/kg

Figure 4: Body-worn for FM Modulation at 12.5KHz Channel Separation; Front towards Ground467.6375 MHz

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Appendix D. DASY System Calibration Certificate

Probe Calibration Certificate

E-mail: cttl@china	III.COM HID://V	www.chinattl.cn	
Client Sun	way	Certificate No: Z17-9	7101
CALIBRATION C	ERTIFICATI	E	
Object	EX3DV4	4 - SN:3836	
Calibration Procedure(s)			
		2-004-01	
•	Calibrati	on Procedures for Dosimetric E-field Probes	
Calibration date:	July 07,	2018	
measurements(SI). The me pages and are part of the ce	asurements and the	aceability to national standards, which rea he uncertainties with confidence probability a	are given on the following
All calibrations have been numidity<70%. Calibration Equipment used	n conducted in th	he closed laboratory facility: environment r calibration)	
All calibrations have been numidity<70%. Calibration Equipment used	n conducted in th	he closed laboratory facility: environment r calibration) Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration
All calibrations have been numidity<70%. Calibration Equipment used Primary Standards	I (M&TE critical for	he closed laboratory facility: environment r calibration)	
All calibrations have been numidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2	I (M&TE critical for ID # 101919	he closed laboratory facility: environment r calibration) Cal Date(Calibrated by, Certificate No.) 27-Jun-18 (CTTL, No.J18X04777)	Scheduled Calibration Jun-19
All calibrations have been numidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91 Reference10dBAttenuator	n conducted in th I (M&TE critical for ID# 101919 101547 101548 18N50W-10dB	he closed laboratory facility: environment r calibration) Cal Date(Calibrated by, Certificate No.) 27-Jun-18 (CTTL, No.J18X04777) 27-Jun-18 (CTTL, No.J18X04777) 27-Jun-18 (CTTL, No.J18X04777)	Scheduled Calibration Jun-19 Jun-19
All calibrations have been numidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91 Reference10dBAttenuator Reference20dBAttenuator	A conducted in the conducted in the conducted in the critical for ID # 101919 101547 101548 18N50W-10dB 18N50W-20dB	he closed laboratory facility: environment r calibration) Cal Date(Calibrated by, Certificate No.) 27-Jun-18 (CTTL, No.J18X04777) 27-Jun-18 (CTTL, No.J18X04777) 13-Mar-18(CTTL,No.J18X01547)	Scheduled Calibration Jun-19 Jun-19 Jun-19
All calibrations have been numidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91 Reference10dBAttenuator Reference20dBAttenuator Reference Probe EX3DV4	Conducted in the conducted in the conducted in the critical for ID # 101919 101547 101548 18N50W-10dB 18N50W-20dB SN 3617	he closed laboratory facility: environment calibration) Cal Date(Calibrated by, Certificate No.) 27-Jun-18 (CTTL, No.J18X04777) 27-Jun-18 (CTTL, No.J18X04777) 13-Mar-18(CTTL, No.J18X01547) 13-Mar-18(CTTL, No.J18X01548) 26-Aug-17(SPEAG,No.EX3-3617_Aug15)	Scheduled Calibration Jun-19 Jun-19 Jun-19 Mar-19 Mar-19 Aug-18
All calibrations have been numidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91 Reference10dBAttenuator Reference20dBAttenuator	A conducted in the conducted in the conducted in the critical for ID # 101919 101547 101548 18N50W-10dB 18N50W-20dB	he closed laboratory facility: environment r calibration) Cal Date(Calibrated by, Certificate No.) 27-Jun-18 (CTTL, No.J18X04777) 27-Jun-18 (CTTL, No.J18X04777) 13-Mar-18(CTTL, No.J18X01547) 13-Mar-18(CTTL, No.J18X01548)	Scheduled Calibration Jun-19 Jun-19 Jun-19 Mar-19 Mar-19 Aug-18
All calibrations have been numidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91 Reference10dBAttenuator Reference20dBAttenuator Reference Probe EX3DV4	Conducted in the conducted in the conducted in the critical for ID # 101919 101547 101548 18N50W-10dB 18N50W-20dB SN 3617	he closed laboratory facility: environment r calibration) Cal Date(Calibrated by, Certificate No.) 27-Jun-18 (CTTL, No.J18X04777) 27-Jun-18 (CTTL, No.J18X04777) 13-Mar-18(CTTL, No.J18X01547) 13-Mar-18(CTTL, No.J18X01548) 26-Aug-17(SPEAG, No.DAE4-1331_Jan16) 21-Jan-18(SPEAG, No.DAE4-1331_Jan16)	Scheduled Calibration Jun-19 Jun-19 Jun-19 Mar-19 Mar-19 Aug-18
All calibrations have been numidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91 Reference10dBAttenuator Reference20dBAttenuator Reference Probe EX3DV4 DAE4 Secondary Standards	Conducted in the conducted in the conducted in the critical for ID# 101919 101547 101548 18N50W-10dB 18N50W-20dB SN 3617 SN 1331 ID #	he closed laboratory facility: environment calibration) Cal Date(Calibrated by, Certificate No.) 27-Jun-18 (CTTL, No.J18X04777) 27-Jun-18 (CTTL, No.J18X04777) 13-Mar-18(CTTL, No.J18X01547) 13-Mar-18(CTTL, No.J18X01548) 26-Aug-17(SPEAG,No.EX3-3617_Aug15)	Scheduled Calibration Jun-19 Jun-19 Jun-19 Mar-19 Mar-19 Aug-18) Jan -19
All calibrations have been humidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91 Reference10dBAttenuator Reference20dBAttenuator Reference Probe EX3DV4 DAE4	Conducted in the conducted in the conducted in the critical for ID# 101919 101547 101548 18N50W-10dB 18N50W-20dB SN 3617 SN 1331 ID # 6201052605	he closed laboratory facility: environment calibration) Cal Date(Calibrated by, Certificate No.) 27-Jun-18 (CTTL, No.J18X04777) 27-Jun-18 (CTTL, No.J18X04777) 13-Mar-18 (CTTL, No.J18X01547) 13-Mar-18 (CTTL, No.J18X01548) 26-Aug-17 (SPEAG, No.EX3-3617_Aug15) 21-Jan-18 (SPEAG, No.DAE4-1331_Jan16 Cal Date(Calibrated by, Certificate No.)	Scheduled Calibration Jun-19 Jun-19 Jun-19 Mar-19 Mar-19 Aug-18) Jan -19 Scheduled Calibration
All calibrations have been numidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91 Reference10dBAttenuator Reference20dBAttenuator Reference Probe EX3DV4 DAE4 Secondary Standards SignalGeneratorMG3700A Network Analyzer E5071C	Conducted in the conducted in the conducted in the critical for ID# 101919 101547 101548 18N50W-10dB 18N50W-20dB SN 3617 SN 1331 ID # 6201052605	he closed laboratory facility: environment calibration) Cal Date(Calibrated by, Certificate No.) 27-Jun-18 (CTTL, No.J18X04777) 27-Jun-18 (CTTL, No.J18X04777) 13-Mar-18(CTTL, No.J18X01547) 13-Mar-18(CTTL, No.J18X01548) 26-Aug-17(SPEAG,No.EX3-3617_Aug15) 21-Jan-18(SPEAG, No.DAE4-1331_Jan16 Cal Date(Calibrated by, Certificate No.) 27-Jun-18 (CTTL, No.J18X04776)	Scheduled Calibration Jun-19 Jun-19 Jun-19 Mar-19 Mar-19 Aug-18) Jan -19 Scheduled Calibration Jun-19
All calibrations have been numidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91 Reference10dBAttenuator Reference20dBAttenuator Reference Probe EX3DV4 DAE4 Secondary Standards SignalGeneratorMG3700A Network Analyzer E5071C	Conducted in the conducted in the conducted in the critical for ID# 101919 101547 101548 18N50W-10dB 18N50W-20dB SN 3617 SN 1331 ID # 6201052605 MY46110673	he closed laboratory facility: environment r calibration) Cal Date(Calibrated by, Certificate No.) 27-Jun-18 (CTTL, No.J18X04777) 27-Jun-18 (CTTL, No.J18X04777) 13-Mar-18(CTTL, No.J18X01547) 13-Mar-18(CTTL, No.J18X01548) 26-Aug-17(SPEAG, No.DAE4-1331_Jan16 Cal Date(Calibrated by, Certificate No.) 27-Jun-18 (CTTL, No.J18X04776) 26-Jan-18 (CTTL, No.J18X00894)	Scheduled Calibration Jun-19 Jun-19 Jun-19 Mar-19 Mar-19 Aug-18) Jan -19 Scheduled Calibration Jun-19 Jan -19
All calibrations have been numidity<70%. Calibration Equipment used Primary Standards Power Meter NRP2 Power sensor NRP-Z91 Power sensor NRP-Z91 Reference10dBAttenuator Reference20dBAttenuator Reference Probe EX3DV4 DAE4 Secondary Standards SignalGeneratorMG3700A	a conducted in the cond	he closed laboratory facility: environment Calibration) Cal Date(Calibrated by, Certificate No.) 27-Jun-18 (CTTL, No.J18X04777) 27-Jun-18 (CTTL, No.J18X04777) 13-Mar-18 (CTTL, No.J18X01547) 13-Mar-18 (CTTL, No.J18X01548) 26-Aug-17 (SPEAG, No.DAE4-1331_Jan16 Cal Date(Calibrated by, Certificate No.) 27-Jun-18 (CTTL, No.J18X04776) 26-Jan-18 (CTTL, No.J18X00894) Function	Scheduled Calibration Jun-19 Jun-19 Jun-19 Mar-19 Mar-19 Aug-18) Jan -19 Scheduled Calibration Jun-19 Jan -19

Certificate No: Z17-97101

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Address: 1/F, Building D, Sogood Science and Technology Park, SanweiCommunity, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China. Tel:(86)755-26066440 Fax:(86)755-26014772 Email:service@anbotek.com



 Add: No.51 Xueyuan Road, Haidian District, Beijing, 100191, China

 Tel: +86-10-62304633-2218
 Fax: +86-10-62304633-2209

 E-mail: cttl@chinattl.com
 <u>Http://www.chinattl.cn</u>

Glossary:

Anbotek 安博检测

Report No.: R0219020005W

Anbotek Testing

Product Safety

TSL tissue simulating liquid NORMx,y,z sensitivity in free space ConvF sensitivity in TSL / NORMx,y,z DCP diode compression point CF crest factor (1/duty_cycle) of the RF signal A,B,C,D modulation dependent linearization parameters Polarization Φ Φ rotation around probe axis Polarization θ θ rotation around an axis that is in the plane normal to probe axis (at measurement center), i θ=0 is normal to probe axis

Connector Angle information used in DASY system to align probe sensor X to the robot coordinate system Calibration is Performed According to the Following Standards:

a) IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", June 2013

FCC ID: 2ASV6-T5

- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300MHz to 3GHz)", February 2005
- c) IEC 62209-2, "Procedure to determine the Specific Absorption Rate (SAR) for wireless communication devices used in close proximity to the human body (frequency range of 30 MHz to 6 GHz)", March 2010

d) KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz" Methods Applied and Interpretation of Parameters:

- NORMx, y,z: Assessed for E-field polarization θ=0 (f≤900MHz in TEM-cell; f>1800MHz: waveguide). NORMx, y,z are only intermediate values, i.e., the uncertainties of NORMx, y,z does not effect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)x,y,z = NORMx,y,z* frequency_response (see Frequency Response Chart). This
 linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the
 frequency response is included in the stated uncertainty of ConvF.
- DCPx, y, z: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics.
- Ax,y,z; Bx,y,z; Cx,y,z; VRx,y,z:A,B,C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f≤800MHz) and inside waveguide using analytical field distributions based on power measurements for f >800MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty valued are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z* ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from±50MHz to±100MHz.
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat
 phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the
 probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

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 <u>Http://www.chinattl.cn</u>

Probe EX3DV4

FCC ID: 2ASV6-T5

SN: 3836

Calibrated: July 07, 2018

Calibrated for DASY/EASY Systems (Note: non-compatible with DASY2 system!)

Certificate No: Z17-97101

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DASY/EASY – Parameters of Probe: EX3DV4 – SN: 3836

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm(µV/(V/m) ²) ^A	0.40	0.46	0.43	±10.8%
DCP(mV) ^B	93.2	100.2	98.0	

Modulation Calibration Parameters

UID	Communication System Name		A dB	B dBõV	С	D dB	VR mV	Unc ^E (k=2)
0	CW	X	0.0	0.0	1.0	0.00	167.8	±2.0%
		Y	0.0	0.0	1.0		182.5	
		Z	0.0	0.0	1.0		176.7	

The reported uncertainty of measurement is stated as the standard uncertainty of Measurement multiplied by the coverage factor k=2, which for a normal distribution Corresponds to a coverage probability of approximately 95%.

^A The uncertainties of Norm X, Y, Z do not affect the E²-field uncertainty inside TSL (see Page 5 and Page 6). ^B Numerical linearization parameter: uncertainty not required.

^E Uncertainly is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

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DASY/EASY – Parameters of Probe: EX3DV4 – SN: 3836

Calibration Parameter Determined in Head Tissue Simulating Media

f [MHz] ^C	Relative Permittivity ^F	Conductivity (S/m) ^F	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unct. (k=2)
450	43.5	0.87	7.12	7.12	7.12	0.20	1.30	±13.3%
750	41.9	0.89	9.43	9.43	9.43	0.30	0.80	±12%
835	41.5	0.90	9.42	9.42	9.42	0.15	1.58	±12%
900	41.5	0.9	9.03	9.03	9.03	0.15	1.46	±12%
1750	40.1	1.37	8.04	8.04	8.04	0.14	1.63	±12%
1900	40.0	1.40	7.60	7.60	7.60	0.16	1.59	±12%
2300	39.5	1.67	7.45	7.45	7.45	0.53	0.68	±12%
2450	39.2	1.80	7.07	7.07	7.07	0.54	0.71	±12%
2600	39.0	1.96	6.96	6.96	6.96	0.61	0.66	±12%
5200	36.0	4.66	5.32	5.32	5.32	0.40	1.42	±13%
5300	35.9	4.76	5.13	5.13	5.13	0.40	1.40	±13%
5500	35.6	4.96	4.85	4.85	4.85	0.40	1.35	±13%
5600	35.5	5.07	4.59	4.59	4.59	0.40	1.45	±13%
5800	35.3	5.27	4.71	4.71	4.71	0.40	1.45	±13%

^c Frequency validity above 300 MHz of ±100MHz only applies for DASY v4.4 and higher (Page 2), else it is restricted to ±50MHz. The uncertainty is the RSS of ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ± 10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency validity can be extended to ± 110 MHz.

^F At frequency below 3 GHz, the validity of tissue parameters (ϵ and σ) can be relaxed to ±10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ϵ and σ) is restricted to ±5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters. ^G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ± 1% for frequencies below 3 GHz and below ± 2% for the frequencies between 3-6 GHz at any distance larger than half the probe tip diameter from the boundary.

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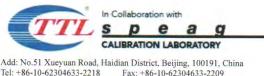
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DASY/EASY – Parameters of Probe: EX3DV4 – SN: 3836

Calibration Parameter Determined in Body Tissue Simulating Media

f [MHz] ^C	Relative Permittivity ^F	Conductivity (S/m) ^F	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unct. (k=2)
450	56.7	0.94	7.33	7.33	7.33	0.13	1.50	±13.3%
750	55.5	0.96	9.38	9.38	9.38	0.30	0.85	±12%
835	55.2	0.97	9.25	9.25	9.25	0.17	1.44	±12%
900	55.0	1.05	8.95	8.95	8.95	0.14	1.60	±12%
1750	53.4	1.49	7.64	7.64	7.64	0.17	1.71	±12%
1900	53.3	1.52	7.33	7.33	7.33	0.18	1.80	±12%
2300	52.9	1.81	7.45	7.45	7.45	0.51	0.80	±12%
2450	52.7	1.95	7.20	7.20	7.20	0.62	0.70	±12%
2600	52.5	2.16	6.99	6.99	6.99	0.52	0.79	±12%
5200	49.0	5.30	4.83	4.83	4.83	0.50	1.25	±13%
5300	48.9	5.42	4.60	4.60	4.60	0.50	1.35	±13%
5500	48.6	5.65	4.32	4.32	4.32	0.50	1.35	±13%
5600	48.5	5.77	4.20	4.20	4.20	0.50	1.40	±13%
5800	48.2	6.00	4.30	4.30	4.30	0.50	1.30	±13%

^c Frequency validity above 300 MHz of ±100MHz only applies for DASY v4.4 and higher (Page 2), else it is restricted to ±50MHz. The uncertainty is the RSS of ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ± 10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency validity can be extended to ± 110 MHz.

^F At frequency below 3 GHz, the validity of tissue parameters (ϵ and σ) can be relaxed to ±10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ϵ and σ) is restricted to ±5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters. ^G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ± 1% for frequencies below 3 GHz and below ± 2% for the frequencies between 3-6 GHz at any distance larger than half the probe tip diameter from the boundary.

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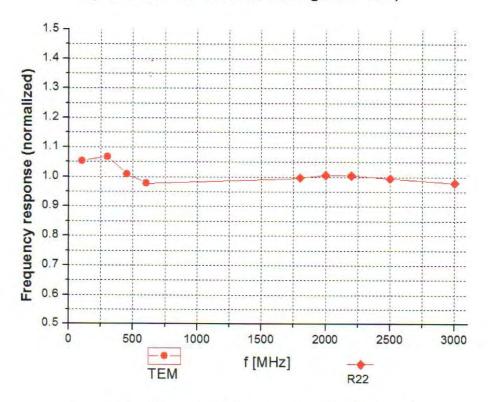
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Frequency Response of E-Field (TEM-Cell: ifi110 EXX, Waveguide: R22)



Uncertainty of Frequency Response of E-field: ±7.5% (k=2)

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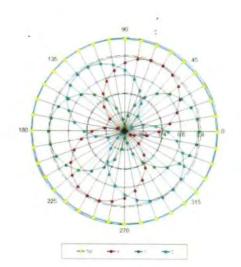


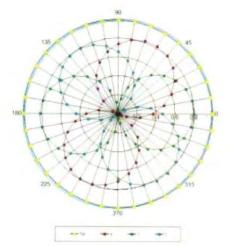
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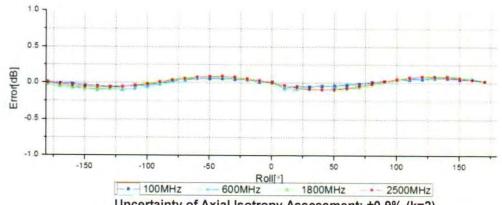
Receiving Pattern (Φ), θ =0°

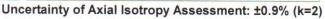
f=600 MHz, TEM

f=1800 MHz, R22









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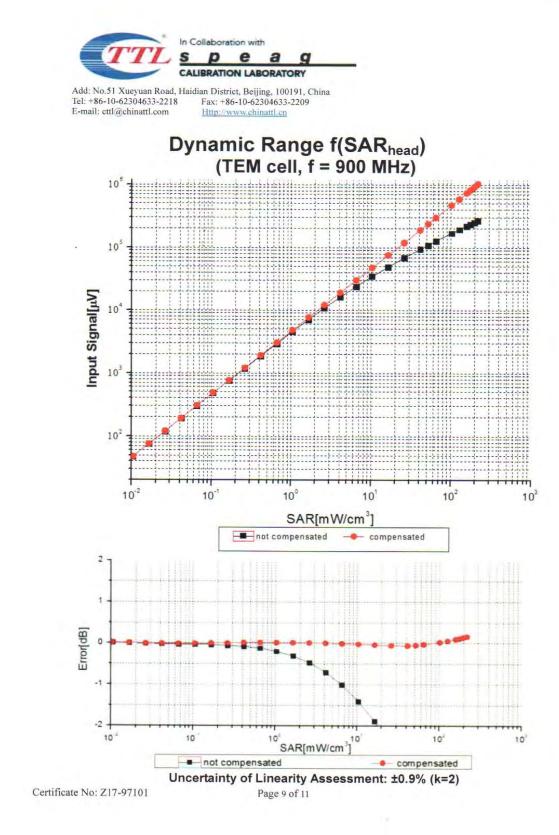
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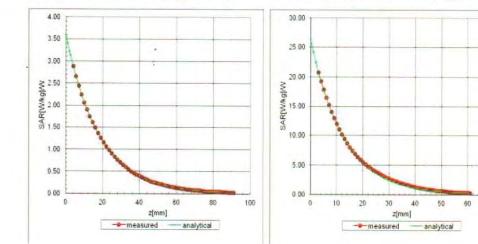


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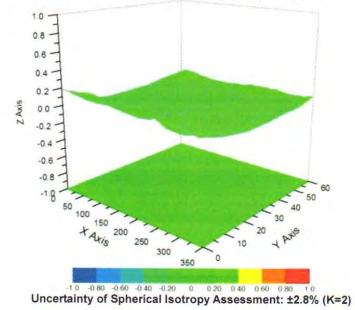
Conversion Factor Assessment

f=900 MHz, WGLS R9(H_convF)

f=1900 MHz, WGLS R22(H_convF)



Deviation from Isotropy in Liquid



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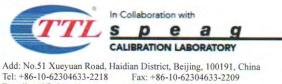
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DASY/EASY – Parameters of Probe: EX3DV4 – SN: 3836

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle (°)	47.9
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disable
Probe Overall Length	337mm
Probe Body Diameter	10mm
Tip Length	9mm
Tip Diameter	2.5mm
Probe Tip to Sensor X Calibration Point	1mm
Probe Tip to Sensor Y Calibration Point	1mm
Probe Tip to Sensor Z Calibration Point	1mm
Recommended Measurement Distance from Surface	1.4mm

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D450V3 Dipole Calibration Certificate

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Calibration Laboratory of	
Schmid & Partner	
Engineering AG	
Zeughausstrasse 43, 8004 Zurich, Switzerland	

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 - Swiss Calibration Service

Accreditation No.: SCS 0108

Certificate No: D450V3-1079 Aug16 CIQ-SZ (Auden) Client CALIBRATION CERTIFICATE 118128 (40M) SAR D450V3 - SN: 1079 Object 50462 QA CAL-15.v8 Calibration procedure(s) Calibration procedure for dipole validation kits below 700 MHz August 29, 2016 Calibration date: This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Cal Date (Certificate No.) Scheduled Calibration ID # **Primary Standards** SN: 104778 06-Apr-16 (No. 217-02288/02289) Apr-17 Power meter NRP 06-Apr-16 (No. 217-02288) Apr-17 SN: 103244 Power sensor NRP-Z91 Apr-17 Power sensor NRP-Z91 SN: 103245 06-Apr-16 (No. 217-02289) Apr-17 SN: 5277 (20x) 05-Apr-16 (No. 217-02293) Reference 20 dB Attenuator 05-Apr-16 (No. 217-02295) Apr-17 Type-N mismatch combination SN: 5047.2 / 06327 Reference Probe ET3DV6 SN: 1507 31-Dec-15 (No. ET3-1507_Dec15) Dec-16 Aug-17 SN: 654 12-Aug-16 (No. DAE4-654_Aug16) DAE4 Scheduled Check Secondary Standards ID # Check Date (in house) SN: GB41293874 06-Apr-16 (No. 217-02285/02284) In house check: Jun-18 Power meter E4419B SN: MY41498087 06-Apr-16 (No. 217-02285) In house check: Jun-18 Power sensor E4412A In house check: Jun-18 Power sensor E4412A SN: 000110210 06-Apr-16 (No. 217-02284 SN: US3642U01700 In house check: Jun-18 RF generator HP 8648C 04-Aug-99 (in house check Jun-16) In house check: Oct-16 Network Analyzer HP 8753E SN: US37390585 18-Oct-01 (in house check Oct-15) Signature Name Function Jeton Kastrati Laboratory Technician Calibrated by: Katja Pokovic Technical Manager Approved by: Issued: August 30, 2016 This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: D450V3-1079_Aug16

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Report No.: R0219020005W

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Calibration Laboratory of Schmid & Partner **Engineering AG** Zeughausstrasse 43, 8004 Zurich, Switzerland



FCC ID: 2ASV6-T5



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Glossary:

TSL	tissue simulating liquid
ConvF	sensitivity in TSL / NORM x,y,z
N/A	not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", June 2013
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- c) IEC 62209-2, "Procedure to determine the Specific Absorption Rate (SAR) for wireless communication devices used in close proximity to the human body (frequency range of 30 MHz to 6 GHz)", March 2010
- d) KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Additional Documentation:

e) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the en of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: D450V3-1079_Aug16

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Swiss Calibration Service

Accreditation No.: SCS 0108

Measurement Conditions

DASY system configuration, as far as not given on page 1.	DASY	system	configuration,	as	far	as	not	given	on	page	1.	
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DASY Version	DASY5	V52.8.8
Extrapolation	Advanced Extrapolation	
Phantom	ELI4 Flat Phantom	Shell thickness: 2 ± 0.2 mm
Distance Dipole Center - TSL	15 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	450 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	43.5	0.87 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	44.3 ± 6 %	0.89 mho/m ± 6 %
Head TSL temperature change during test	< 0.5 °C		

SAR result with Head TSL

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	1.16 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	4.58 W/kg ± 18.1 % (k=2)
CAR and and 10 cm ³ (10 a) of Hood TSI	condition	
SAR averaged over 10 cm ³ (10 g) of Head TSL	condition 250 mW input power	0.775 W/kg

Body TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	56.7	0.94 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	56.7 ± 6 %	0.95 mho/m ± 6 %
Body TSL temperature change during test	< 0.5 °C		

SAR result with Body TSL

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	250 mW input power	1.16 W/kg
SAR for nominal Body TSL parameters	normalized to 1W	4.60 W/kg ± 18.1 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR measured	250 mW input power	0.764 W/kg
SAR for nominal Body TSL parameters	normalized to 1W	3.03 W/kg ± 17.6 % (k=2)

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Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters with Head TSL

Impedance, transformed to feed point	58.0 Ω - 2.9 jΩ		
Return Loss	- 22.0 dB		

Antenna Parameters with Body TSL

Impedance, transformed to feed point	56.1 Ω - 5.8 jΩ	
Return Loss	22.0 dB	

General Antenna Parameters and Design

Electrical Delay (one direction)	1.348 ns

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG		
Manufactured on	March 03, 2011		

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FCC ID: 2ASV6-T5

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DASY5 Validation Report for Head TSL

Date: 29.08.2

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 450 MHz; Type: D450V3; Serial: D450V3 - SN: 1079

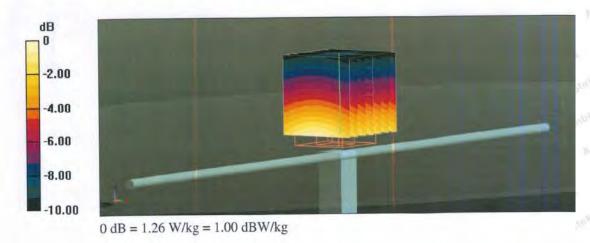
Communication System: UID 0 - CW; Frequency: 450 MHz Medium parameters used: f = 450 MHz; σ = 0.89 S/m; ϵ_r = 44.3; ρ = 1000 kg/m³ Phantom section: Flat Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: ET3DV6 SN1507; ConvF(6.58, 6.58, 6.58); Calibrated: 31.12.2015;
- Sensor-Surface: 4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn654; Calibrated: 12.08.2016
- Phantom: ELI v4.0; Type: QDOVA001BB; Serial: TP:1003
- DASY52 52.8.8(1258); SEMCAD X 14.6.10(7372)

Dipole Calibration for Head Tissue/d=15mm, Pin=250mW/Zoom Scan (7x7x7)/Cube 0:

Measurement grid: dx=5mm, dy=5mm, dz=5mm Reference Value = 39.87 V/m; Power Drift = -0.05 dB Peak SAR (extrapolated) = 1.69 W/kg SAR(1 g) = 1.16 W/kg; SAR(10 g) = 0.775 W/kg Maximum value of SAR (measured) = 1.26 W/kg



Certificate No: D450V3-1079_Aug16

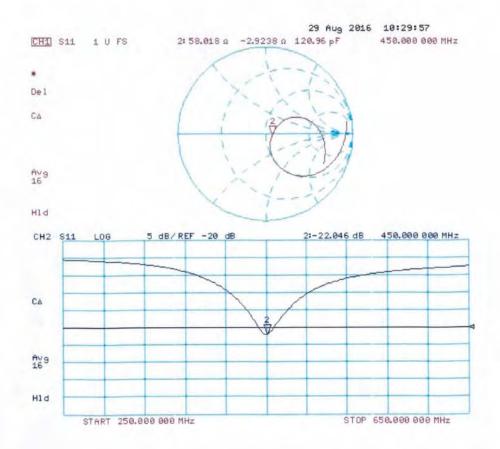
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Impedance Measurement Plot for Head TSL



Certificate No: D450V3-1079_Aug16

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FCC ID: 2ASV6-T5

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DASY5 Validation Report for Body TSL

Date: 29.08.2016

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 450 MHz D450V3; Type: D450V3; Serial: D450V3 - SN:1079

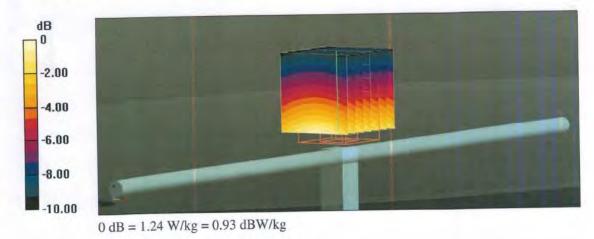
Communication System: UID 0 - CW; Frequency: 450 MHz Medium parameters used: f = 450 MHz; σ = 0.95 S/m; ϵ_r = 56.7; ρ = 1000 kg/m³ Phantom section: Flat Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: ET3DV6 SN1507; ConvF(6.99, 6.99, 6.99); Calibrated: 31.12.2015;
- Sensor-Surface: 4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn654; Calibrated: 12.08.2016
- Phantom: ELI v4.0; Type: QDOVA001BB; Serial: TP:1003
- DASY52 52.8.8(1258); SEMCAD X 14.6.10(7372)

Dipole Calibration for Body Tissue/d=15mm, Pin=250mW/Zoom Scan (7x7x7)/Cube 0:

Measurement grid: dx=5mm, dy=5mm, dz=5mm Reference Value = 37.17 V/m; Power Drift = -0.01 dB Peak SAR (extrapolated) = 1.82 W/kg SAR(1 g) = 1.16 W/kg; SAR(10 g) = 0.764 W/kg Maximum value of SAR (measured) = 1.24 W/kg



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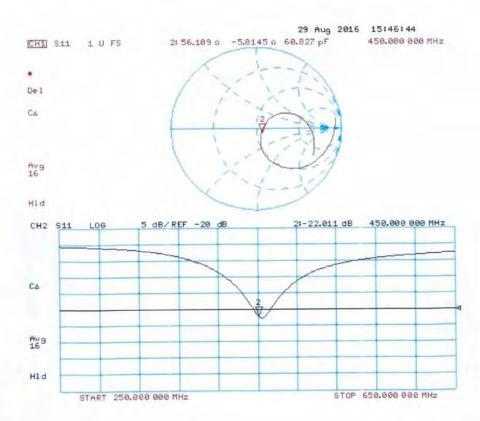
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Impedance Measurement Plot for Body TSL



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Client i CCI			ate No: Z18-97054
CALIBRATION 0	CERTIFICATI	£	
Object	DAE4-5	SN: 1373	
Calibration Procedure(s)			
	FF-Z11-0 Calibrati	002-01 on Procedure for the Data Ac	quisition Electronics
	(DAEx)		
Calibration date:	March 2	2, 2018	
This calibration Certifica	te documents the tr	aceability to national standards,	which realize the physical units of probability are given on the following
pages and are part of the		le uncensamlles war compense i	Noodminy are given on the following
All calibrations have be	en conducted in ti	ne closed laboratory facility: er	wironment temperature(22±3)°C and
humidity<70%.			
Calibration Equipment us	sed (M&TE critical fo	r calibration)	
Primary Standards	ID # Cal	Date(Calibrated by, Certificate N	b.) Scheduled Calibration
Process Calibrator 753	1971018	27-Jun-17 (CTTL, No. J17X05859	June-18
		5 million (1997)	
Calibrated by:	Name Yu Zongying	Function SAR Test Engineer	Signature
			at the
Reviewed by:	Lin Hao	SAR Test Engineer	717-7-0
Approved by	Qi Dianyuan	SAR Project Leader	200
			Issued: March 23, 2018

Certificate No: Z18-97054

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Anbotek Product Safety Report No.: R0219020005W

FCC ID: 2ASV6-T5





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Glossary: DAE

Connector angle

data acquisition electronics information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters:

- DC Voltage Measurement. Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The report provide only calibration results for DAE, it does not contain other performance test results.

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Add: No.51 Xueyumi Road, Haidian District, Beijing, 100191, Chian Tel: +86-10-62304633-2512 Pax: +16-10-62304633-2504 E-mail: ettlogehimatt.com Http://www.chimattLen

DC Voltage Measurement A/D - Converter Resolution nominal High Range ILSB = 6,1µV, full range = -100...+300 mV Low Range ILSB = 61nV, full range = -1,....+3mV DASY measurement parameters. Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	x	Ŷ	z
High Range	403.902 ± 0.15% (k=2)	403.864 ± 0.15% (k=2)	404.160 ± 0.15% (k=2)
Low Range	3.98605±0.7% (K=2)	4.00729 ± 0.7% (k=2)	4.01146 ± 0.7% (k=2)

Connector Angle

Connector Angle to be used in DASY system	219.5°±1.°
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*****END OF REPORT*****

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